C-3-2

Formation and Characterization of Self-Organized Ferromagnetic Nanostructures in Epitaxially Grown Mn-Doped Ge Thin Films

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1. Introduction

Over recent years, Si- and Ge-based ferromagnetic semiconductors (FSs) have attracted considerable attention not only in the research field of semiconductor spintronics but also integrated electronics, owing to their suitability and compatibility with Si CMOS technology. In particular, Ge-based FSs would be a key material for future spintronics, since Ge plays an important role for advanced CMOS devices [1].

After the first report on ferromagnetism in Mn-doped Ge thin film [2], many investigations have been done for Ge-based FSs, including controversy over the origin of ferromagnetism in Mn-doped Ge films. Recently, we reported that highly-Mn-contained ferromagnetic *amorphous* Ge_{1-x}Mn_x (a-Ge_{1-x}Mn_x) nanocolumns with high Mn content (x~20%) were precipitated in the pure Ge matrix when Mn-doped Ge thin films were epitaxially grown on Ge(001) by low-temperature molecular beam epitaxy (LT-MBE). We also found that precipitated a-Ge_{1-x}Mn_x (that behaves as an amorphous ferromagnetic semiconductor [3]) is the origin of ferromagnetism in the Mn-doped Ge films [4]. In this paper, we investigate formation and characterization of self-organized a-Ge_{1-x}Mn_x nanocolumns in epitaxially grown Mn-doped Ge thin films.

2. MBE Growth and Structural Characterization

We prepared $Ge_{1-x}Mn_x$ films grown on Ge (001) substrates by LT-MBE technique with a growth rate $R_{\rm G} = 30$ nm/h at various substrate temperatures $T_{\rm S}$ (= 35 - 300°C) and with various growth rate $R_{\rm G}$ (= 30 - 150 nm/h) at a substrate temperature $T_{\rm S} = 100^{\circ}$ C. Note that our previously investigated Ge_{0.94}Mn_{0.06} film ($R_{\rm G} = 30$ nm/h and $T_{\rm S} =$ 100°C) contained the precipitation of a-Ge_{0.80}Mn_{0.20} nanocolumns in the pure Ge matrix [4]. Fig. 1 shows magnetic circular dichroism (MCD) spectra of Ge_{0.94}Mn_{0.06} films with $R_{\rm G} = 30$ nm/h at several $T_{\rm S}$, measured with reflection configuration at 10 K. For $T_{\rm S} = 100^{\circ}$ C, two MCD peaks at E1 critical point of Ge and 2 eV originating from nanocluster were observed, indicating phase separation occurred in the film. By lowering $T_{\rm S}$ from 100°C, these two peaks were merged into one peak at 2.3 eV as shown in the figure. However, both ferromagnetic and paramagnetic components were clearly observed in the magnetic-field dependence of MCD intensity even for the films grown at $T_{\rm S}$ =

75°C and 35°C (Fig. 2). From TEM observations, self-organized nanocolumnar ordering was found to be formed in the $T_{\rm S}$ range between 35°C and 100°C. On the other hand, when $T_{\rm S}$ increased to 300°C, ferromagnetic Mn₅Ge₃ clusters were segregated in the film, and no nanocolumnar structure was formed in the film.

Fig. 3 shows a TEM image of $Ge_{0.94}Mn_{0.06}$ film with R_G = 150 nm/h at $T_S = 100^{\circ}C$ (where R_G was 5 times larger than that for the samples shown in Fig. 1). The film contained the precipitation of a-Ge_{0.91}Mn_{0.09} nanocolumns in the Ge_{0.97}Mn_{0.03} matrix. The diameter of the nanocolumns was ~5 nm, which is almost the same as the above described cases for $R_G = 30$ nm/h and $T_S = 35 - 100^{\circ}C$. It was found that the Mn distribution was changed by increasing R_G ; the Mn concentration x_{nc} of the nanocolumns decreased with increasing R_G , but that of the matrix region increased with R_G . From MCD measurements, we also observed that the contribution of the paramagnetic component described above was weaken with increasing R_G and disappeared at $R_G = 150$ nm/h.

Fig. 4 shows Curie temperature $T_{\rm C}$ and Mn concentration x_{nc} of nanocolumns in Ge_{0.94}Mn_{0.06} films as a function of $R_{\rm G}$. The x_{nc} of the nanocolumns decreased with increasing $R_{\rm G}$, and also $T_{\rm C}$ decreased with increasing $R_{\rm G}$. Fig. 5 shows coercive force $H_{\rm C}$ of the Ge_{0.94}Mn_{0.06} films with $R_{\rm G} = 30$ - 150 nm/h. When $R_{\rm G} > 90$ nm/h, $H_{\rm C}$ was suddenly dropped and kept almost a constant value, as shown in Fig. 5.

3. Summary

The above described results show that the Mn concentration x_{nc} of the self-organized nanocolumns in the epitaxially grown Mn-doped Ge films can be manipulated, i.e., by lowering T_S or increasing R_G , x_{nc} was decreased and Mn atoms were distributed into the Ge matrix, and eventually magnetic property was changed, with keeping the size of nanocolumns and their spacing. The nanocolumnar ordering is explained by spinodal decomposition in ferromagnetic semiconductor [5]. The columnar ferromagnetic clusters presented here could be used as a magnetization-manipulable nano-magnet in Ge, which may lead to advanced nanoscale spin devices based on group-IV semiconductors.

Acknowledgments

One of the authors (S. Y.) gratefully acknowledges Research Fellowships of Japan Society for the Promotion of Science (JSPS) for Young Scientists. This work is partially supported by Grant-in-Aid for Scientific Research, Next-Generation IT Program from MEXT, the Special Coordination Programs for Promoting Science and Technology, and Kurata-Memorial Hitachi Science Foundation.

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Fig. 1 MCD spectra of $Ge_{0.94}Mn_{0.06}$ films with $R_G = 30$ nm/h at $T_S = 35$, 75, 100, 300°C measured at 10 K under applied field of 1 T.



Fig. 2 MCD hysteresis of $Ge_{0.94}Mn_{0.06}$ films with $R_G = 30$ nm/h at $T_S = 35^{\circ}C$ measured at 2.3 eV (Ge E₁) and 3.5 eV. At the energy of E₁, paramagnetic component (curve (c)) was superimposed.



Fig. 3 TEM image of $Ge_{0.94}Mn_{0.06}$ film with $R_G = 30$ nm/h and $T_S = 100^{\circ}C$. Mn was segregated into amorphous clusters. (a, b): cross-sectional view (c): plan-view



Fig. 4 $T_{\rm C}$ (circle plots) and Mn concentration at a-Ge_{1-y}Mn_y nanocolumn (triangle plots) of Ge_{0.94}Mn_{0.06} films grown at $T_{\rm S}$ = 100°C as a function of growth rate $R_{\rm G}$.



Fig. 5 Coercive force (*Hc*) of $Ge_{0.94}Mn_{0.06}$ films grown at $T_{\rm S} = 100^{\circ}C$ as a function of growth rate $R_{\rm G}$